STL23NM60ND

N-channel 600 V, 0.150 Ω, 19.5 A, FDmesh™ II Power MOSFET (with fast diode) PowerFLAT™ (8x8) HV

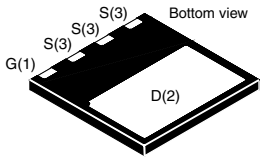
Preliminary data

Features

Type	V_{DSS} ($@T_{jmax}$)	$R_{DS(on)}$ max	I_D
STL23NM60ND	650 V	< 0.180 Ω	19.5 A(1)

1. This value is rated according to $R_{thj\text{-}case}$.

- The worldwide best $R_{DS(on)}$ * area amongst the fast recovery diode devices
- 100% avalanche tested
- Low input capacitance and gate charge
- Low gate input resistance
- High dv/dt and avalanche capabilities



PowerFLAT™(8x8) HV

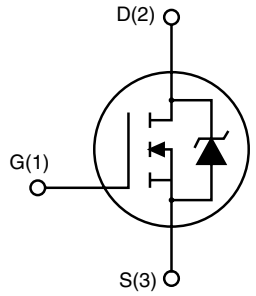
Application

- Switching applications

Description

The FDmesh™ II series belongs to the second generation of MDmesh™ technology. This revolutionary Power MOSFET associates a new vertical structure to the company's strip layout and associates all advantages of reduced on-resistance and fast switching with an intrinsic fast-recovery body diode.It is therefore strongly recommended for bridge topologies, in particular ZVS phase-shift converters.

Figure 1. Internal schematic diagram



AM01475v1

Table 1. Device summary

Order code	Marking	Package	Packaging
STL23NM60ND	23NM60ND	PowerFLAT™ 8x8 HV	Tape and reel

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1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source voltage (V_{GS} = 0)	600	V
V_{GS}	Gate-source voltage	± 25	V
I_D (1)	Drain current (continuous) at T_C = 25 °C	19.5	A
I_D (1)	Drain current (continuous) at T_C = 100 °C	11.7	A
I_{DM} (1),(2)	Drain current (pulsed)	78	A
I_D(3)	Drain current (continuous) at T_C = 25 °C	2.75	A
I_D(3)	Drain current (continuous) at T_C = 100 °C	1.75	A
I_{DM}(2),(3)	Drain current (pulsed)	11	A
P_{TOT} (3)	Total dissipation at T_C = 25 °C (steady state)	150	W
P_{TOT} (1)	Total dissipation at T_C = 25 °C (steady state)	3	W
I_{AR}	Avalanche current, repetitive or not-repetitive (pulse width limited by T_j max)	9	A
E_{AS}	Single pulse avalanche energy (starting T_j = 25 °C, I_D = I_{AR}, V_{DD} = 50 V)	700	mJ
dv/dt (4)	Peak diode recovery voltage slope	40	V/ns
T_{stg}	Storage temperature	- 55 to 150	°C
T_j	Max. operating junction temperature	150	°C

1. The value is rated according to $R_{thj\text{-}case}$
2. Pulse width limited by safe operating area
3. When mounted on FR-4 board of inch², 2oz Cu
4. $I_{SD} \leq 19.5$ A, di/dt $\leq$ 400 A/µs, $V_{Peak} < V_{(BR)DSS}$

Table 3. Thermal data

Symbol	Parameter	Value	Unit
$R_{thj\text{-}case}$	Thermal resistance junction-case max	0.83	°C/W
$R_{thj\text{-}amb}$ (1)	Thermal resistance junction-amb max	45	°C/W
T_l	Maximum lead temperature for soldering purposes	300	°C

1. When mounted on 1inch² FR-4 board, 2 oz Cu

2 Electrical characteristics

(T_{CASE} = 25 °C unless otherwise specified)

Table 4. On/off states

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	I_D = 1 mA, V_{GS}= 0	600			V
dv/dt(1)	Drain-source voltage slope	V_{DD} = 480 V, I_D = 19.5 A, V_{GS} = 10 V		48		V/ns
I_{DSS}	Zero gate voltage drain current (V_{GS} = 0)	V_{DS} = Max rating, V_{DS} = Max rating, @125 °C			1 100	µA µA
I_{GSS}	Gate body leakage current (V_{DS} = 0)	V_{GS} = ±20 V			100	nA
$V_{GS(th)}$	Gate threshold voltage	V_{DS}= V_{GS}, I_D = 250 µA	3	4	5	V
$R_{DS(on)}$	Static drain-source on resistance	V_{GS}= 10 V, I_D= 10 A		0.150	0.180	Ω

1. Characteristic value at turn off on inductive load

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
C_{iss} C_{oss} C_{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V_{DS} = 50 V, f =1 MHz, V_{GS} = 0	-	2050 80 8	-	pF pF pF
$C_{oss\ eq.}$(1)	Equivalent output capacitance	V_{GS} = 0, V_{DS} = 0 to 480 V	-	318	-	pF
Rg	Gate input resistance	f=1 MHz Gate DC Bias=0 Test signal level=20 mV open drain	-	4	-	Ω
Q_g Q_{gs} Q_{gd}	Total gate charge Gate-source charge Gate-drain charge	V_{DD} = 480 V, I_D = 19.5 A V_{GS} = 10 V (see *Figure 3*)	-	70 10 30	-	nC nC nC

1. $C_{oss\ eq.}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$ t_r $t_{d(off)}$ t_f	Turn-on delay time Rise time Turn-off delay time Fall time	V_{DD} = 300 V, I_D = 10 A, R_G = 4.7 Ω, V_{GS} = 10 V (see *Figure 2*)	-	25 45 90 40	-	ns ns ns ns

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
I_{SD} I_{SDM}(1)	Source-drain current Source-drain current (pulsed)		-		19.5 78	A A
V_{SD}(2)	Forward on voltage	I_{SD} = 19.5 A, V_{GS}=0	-		1.3	V
t_{rr} Q_{rr} I_{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I_{SD} = 19.5 A, di/dt =100 A/µs, V_{DD} = 100 V (see *Figure 4*)	-	190 1.2 13		ns µC A
t_{rr} Q_{rr} I_{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	V_{DD} = 100 V di/dt =100 A/µs, I_{SD} = 19.5 A, T_j = 150 °C (see *Figure 4*)	-	260 2.0 15		ns µC A

1. Pulse width limited by safe operating area.
2. Pulsed: pulse duration = 300µs, duty cycle 1.5%

3 Test circuits

Figure 2. Switching times test circuit for resistive load

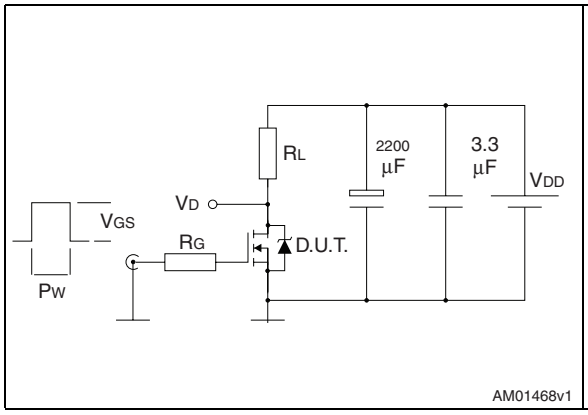


Figure 3. Gate charge test circuit

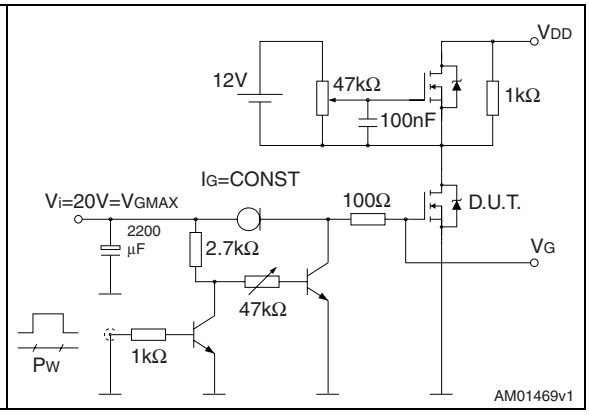


Figure 4. Test circuit for inductive load switching and diode recovery times

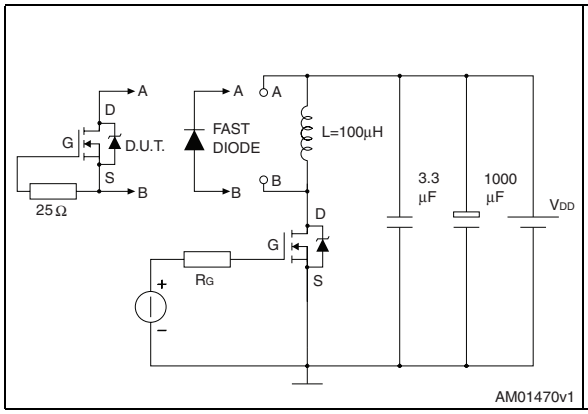


Figure 5. Unclamped inductive load test circuit

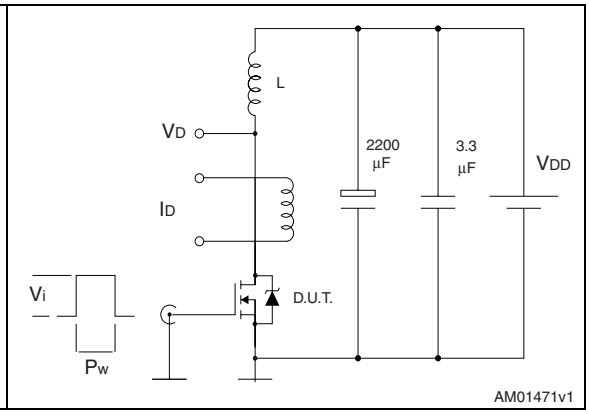


Figure 6. Unclamped inductive waveform

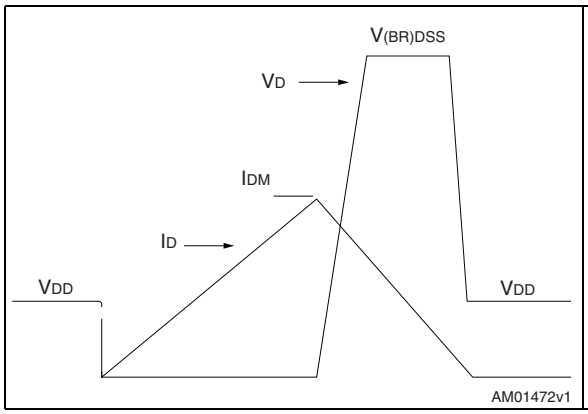
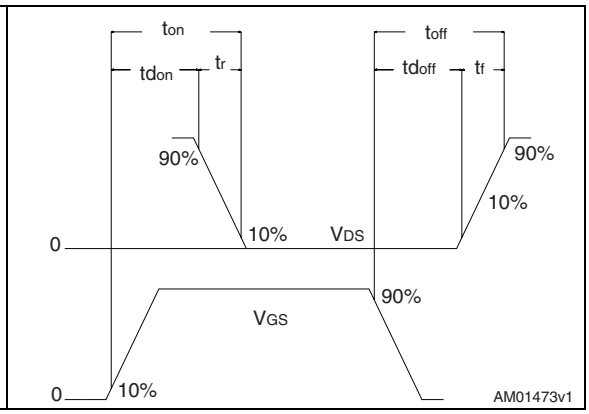


Figure 7. Switching time waveform



4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

Table 8. PowerFLAT™ 8x8 HV mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	0.80	0.90	1.00
A1		0.02	0.05
b	0.95	1.00	1.05
c		0.10	
D		8.00	
E		8.00	
D2	7.05	7.20	7.30
E2	4.15	4.30	4.40
e		2.00	
L	0.40	0.50	0.60

Figure 8. PowerFLAT™ 8x8 HV drawing mechanical data

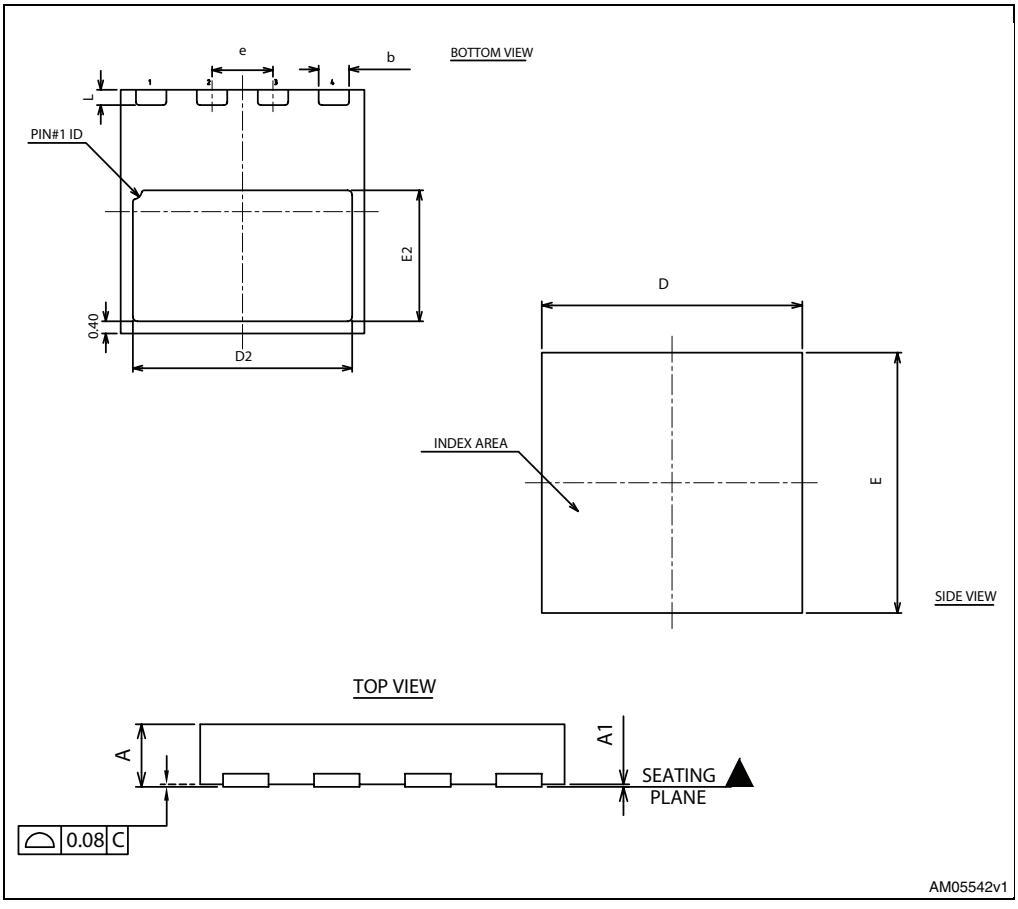
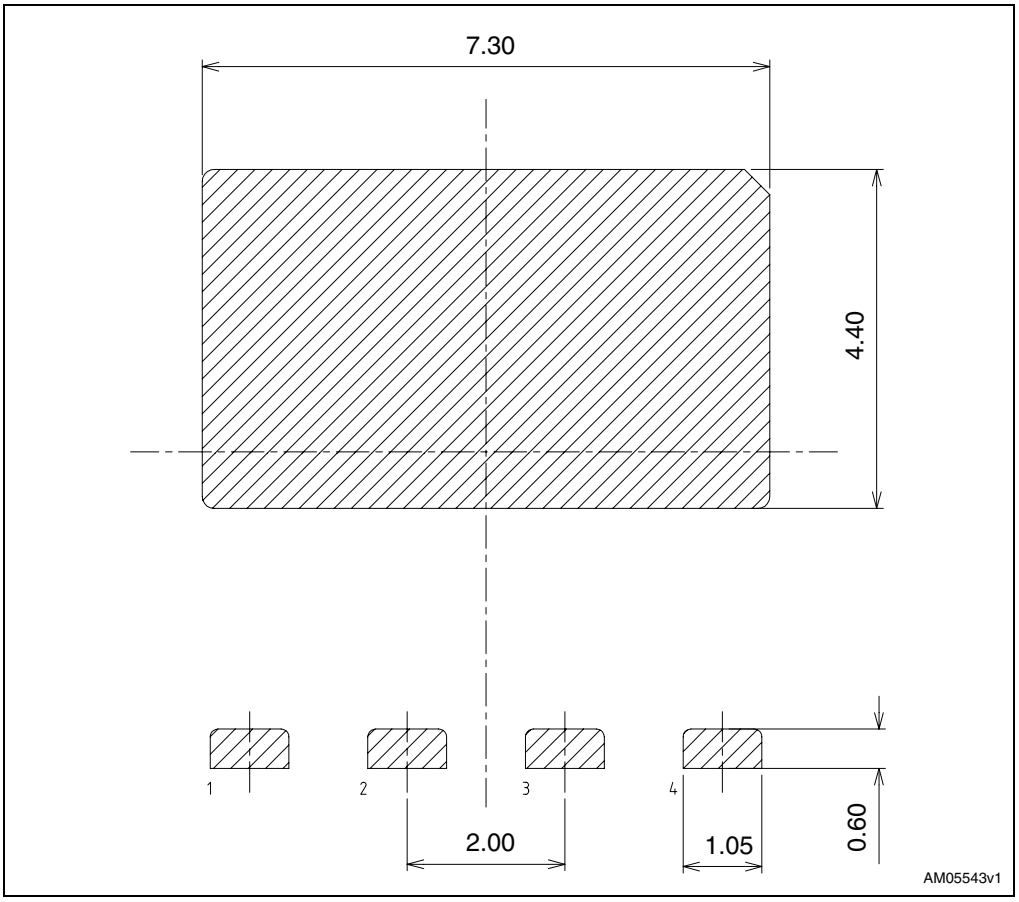


Figure 9. PowerFLAT™ 8x8 HV recommended footprint



5 Revision history

Table 9. Document revision history

Date	Revision	Changes
28-Apr-2010	1	First release

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